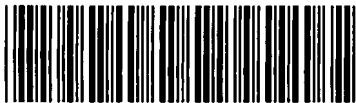


**Search Notes**

Application/Control No.

10/600,146

Examiner

Soon D. Hyun

Applicant(s)/Patent under  
Reexamination

ABROL ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
370/229- 231,235,252,253,466,469,320,342,44 1; 709/223-225,227-229	4/25/2007	HY